

**Notice of References Cited**

Application/Control No.

10/825,253

Applicant(s)/Patent Under  
Reexamination  
KIM ET AL.

Examiner

Christine T. Mui

Art Unit

1709

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,366,609	11-1994	White et al.	204/403.04
*	B	US-6,413,213	07-2002	Essenpreis et al.	600/300
*	C	US-2003/0204313	10-2003	Ou-Yang et al.	702/19
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	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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